

ISO6731 General-Purpose Triple-Channel Digital Isolator with Robust EMC

1 Features

- 50 Mbps data rate
- Robust isolation barrier:
 - High lifetime at 1060 V_{RMS} working voltage
 - Up to 5000 V_{RMS} isolation rating
 - Up to 10 kV surge capability
 - ±75 kV/μs typical CMTI
- Wide supply range: 1.71 V to 1.89 V and 2.25 V to 5.5 V
- 1.71 V to 5.5 V level translation
- Default output *high* (ISO6731) and *low* (ISO6731F) options
- Wide temperature range: –40°C to 125°C
- 1.6 mA per channel typical at 1 Mbps
- Low propagation delay: 11 ns typical
- Robust electromagnetic compatibility (EMC)
 - System-level ESD, EFT, and surge immunity
 - ±8 kV IEC 61000-4-2 contact discharge protection across isolation barrier
 - Low emissions
- Wide-SOIC (DW-16) Package
- [Safety-Related Certifications](#) (pending):
 - DIN V VDE 0884-11:2017-01
 - UL 1577 component recognition program
 - IEC 60950-1, IEC 62368-1, IEC 61010-1, IEC60601-1 and GB 4943.1-2011 certifications

2 Applications

- [Power supplies](#)
- [Grid, Electricity meter](#)
- [Motor drives](#)
- [Factory automation](#)
- [Building automation](#)
- [Lighting](#)
- [Appliances](#)

3 Description

The ISO6731 device is a high-performance, triple-channel digital isolators ideal for cost-sensitive applications requiring up to 5000 V_{RMS} isolation ratings per UL 1577. This device is also certified by VDE, TUV, CSA, and CQC.

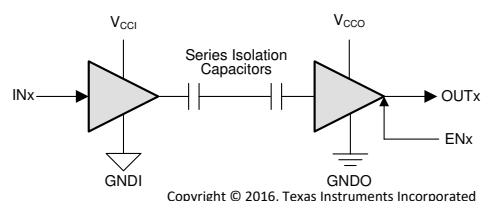
The ISO6731 devices provides high electromagnetic immunity and low emissions at low power consumption, while isolating CMOS or LVCMOS digital I/Os. Each isolation channel has a logic input and output buffer separated by TI's double capacitive silicon dioxide (SiO₂) insulation barrier. This device comes with enable pins which can be used to put the respective outputs in high impedance for multi-master driving applications. The ISO6731 device has two forward and one reverse-direction channels. In the event of input power or signal loss, the default output is *high* for the device without suffix F and *low* for the device with suffix F. See [Device Functional Modes](#) section for further details.

Used in conjunction with isolated power supplies, this device helps prevent noise currents on data buses, such as UART, SPI, RS-485, RS-232, and CAN from damaging sensitive circuitry. Through innovative chip design and layout techniques, the electromagnetic compatibility of the ISO6731 device has been significantly enhanced to ease system-level ESD, EFT, surge, and emissions compliance. The ISO6731 device is available in a 16-pin SOIC wide-body (DW) package and is a pin-to-pin upgrade to the older generations.

Device Information

PART NUMBER ⁽¹⁾	PACKAGE	BODY SIZE (NOM)
ISO6731, ISO6731F	SOIC (DW)	10.30 mm × 7.50 mm

- (1) For all available packages, see the orderable addendum at the end of the data sheet.



V_{CCI}=Input supply, V_{CCO}=Output supply
GNDI=Input ground, GNDO=Output ground

Simplified Schematic



Table of Contents

1 Features	1	6.20 Switching Characteristics—1.8-V Supply	16
2 Applications	1	7 Parameter Measurement Information	17
3 Description	1	8 Detailed Description	19
4 Revision History	2	8.1 Overview.....	19
5 Pin Configuration and Functions	3	8.2 Functional Block Diagram.....	19
6 Specifications	4	8.3 Feature Description.....	20
6.1 Absolute Maximum Ratings	4	8.4 Device Functional Modes.....	21
6.2 ESD Ratings	4	9 Application and Implementation	22
6.3 Recommended Operating Conditions	5	9.1 Application Information.....	22
6.4 Thermal Information	6	9.2 Typical Application.....	22
6.5 Power Ratings	6	10 Power Supply Recommendations	25
6.6 Insulation Specifications	7	11 Layout	26
6.7 Safety-Related Certifications	8	11.1 Layout Guidelines.....	26
6.8 Safety Limiting Values	8	11.2 Layout Example.....	27
6.9 Electrical Characteristics—5-V Supply	9	12 Device and Documentation Support	28
6.10 Supply Current Characteristics—5-V Supply	9	12.1 Documentation Support.....	28
6.11 Electrical Characteristics—3.3-V Supply	10	12.2 Receiving Notification of Documentation Updates.....	28
6.12 Supply Current Characteristics—3.3-V Supply	10	12.3 Support Resources.....	28
6.13 Electrical Characteristics—2.5-V Supply	11	12.4 Trademarks.....	28
6.14 Supply Current Characteristics—2.5-V Supply	11	12.5 Electrostatic Discharge Caution.....	28
6.15 Electrical Characteristics—1.8-V Supply	12	12.6 Glossary.....	28
6.16 Supply Current Characteristics—1.8-V Supply	12	13 Mechanical, Packaging, and Orderable Information	28
6.17 Switching Characteristics—5-V Supply	13	13.1 Package Option Addendum.....	29
6.18 Switching Characteristics—3.3-V Supply	14	13.2 Tape and Reel Information.....	30
6.19 Switching Characteristics—2.5-V Supply	15		

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
January 2021	*	Initial Release

5 Pin Configuration and Functions

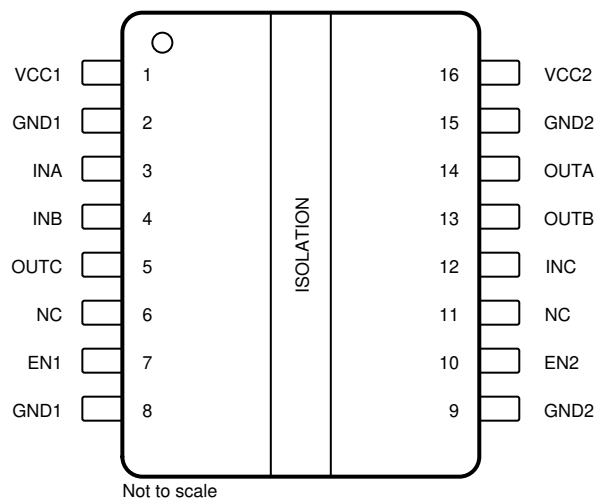


Figure 5-1. ISO6731 DW Package 16-Pin SOIC-WB Top View

Table 5-1. Pin Functions

PIN		I/O	DESCRIPTION
NAME	ISO6731		
EN1	7	I	Output enable 1. Output pins on side 1 are enabled when EN1 is high or open and in high-impedance state when EN1 is low.
EN2	10	I	Output enable 2. Output pins on side 2 are enabled when EN2 is high or open and in high-impedance state when EN2 is low.
GND1	2, 8	—	Ground connection for V_{CC1}
GND2	9, 15	—	Ground connection for V_{CC2}
INA	3	I	Input, channel A
INB	4	I	Input, channel B
INC	12	I	Input, channel C
IND	-	I	Input, channel D
NC	6, 11		Not connected
OUTA	14	O	Output, channel A
OUTB	13	O	Output, channel B
OUTC	5	O	Output, channel C
OUTD	-	O	Output, channel D
V_{CC1}	1	—	Power supply, side 1
V_{CC2}	16	—	Power supply, side 2

6 Specifications

6.1 Absolute Maximum Ratings

See⁽¹⁾

		MIN	MAX	UNIT
Supply voltage ⁽²⁾	V_{CC1}, V_{CC2}	-0.5	6	V
Voltage at INx, OUTx, ENx	V	-0.5	$V_{CCX} + 0.5$ ⁽³⁾	V
Output current	I_o	-15	15	mA
Temperature	Operating junction temperature, T_J		150	°C
	Storage temperature, T_{stg}	-65	150	°C

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values except differential I/O bus voltages are with respect to the local ground terminal (GND1 or GND2) and are peak voltage values
- (3) Maximum voltage must not exceed 6 V.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±6000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1500	
		Contact discharge per IEC 61000-4-2; Isolation barrier withstand test ^{(3) (4)}	±8000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
- (3) IEC ESD strike is applied across the barrier with all pins on each side tied together creating a two-terminal device.
- (4) Testing is carried out in air or oil to determine the intrinsic contact discharge capability of the device.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
V _{CC1} ⁽¹⁾	Supply Voltage Side 1	V _{CC} = 1.8 V	1.71		1.89	V
V _{CC1} ⁽¹⁾	Supply Voltage Side 1	V _{CC} = 2.5 V to 5 V	2.25		5.5	V
V _{CC2} ⁽¹⁾	Supply Voltage Side 2	V _{CC} = 1.8 V	1.71		1.89	V
V _{CC2} ⁽¹⁾	Supply Voltage Side 2	V _{CC} = 2.5 V to 5 V	2.25		5.5	V
V _{CC} (UVLO+)	UVLO threshold when supply voltage is rising			1.53	1.71	V
V _{CC} (UVLO-)	UVLO threshold when supply voltage is falling		1.1	1.41		V
V _{hys} (UVLO)	Supply voltage UVLO hysteresis		0.08	0.13		V
V _{IH}	High level Input voltage		0.7 x V _{CCI} ⁽²⁾		V _{CCI}	V
V _{IL}	Low level Input voltage		0	0.3 x V _{CCI}		V
I _{OH}	High level output current	V _{CCO} = 5 V ⁽²⁾	-4			mA
		V _{CCO} = 3.3 V	-2			mA
		V _{CCO} = 2.5 V	-1			mA
		V _{CCO} = 1.8 V	-1			mA
I _{OL}	Low level output current	V _{CCO} = 5 V			4	mA
		V _{CCO} = 3.3 V			2	mA
		V _{CCO} = 2.5 V			1	mA
		V _{CCO} = 1.8 V			1	mA
DR	Data Rate		0		50	Mbps
T _A	Ambient temperature		-40	25	125	°C

(1) V_{CC1} and V_{CC2} can be set independent of one another

(2) V_{CCI} = Input-side V_{CC}; V_{CCO} = Output-side V_{CC}

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		ISO673x	UNIT
		DW (SOIC)	
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	73	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	36.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	40.4	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	17	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	39.9	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics application report](#).

6.5 Power Ratings

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ISO6731						
P_D	Maximum power dissipation (both sides)	$V_{CC1} = V_{CC2} = 5.5\text{ V}$, $T_J = 150^\circ\text{C}$, $C_L = 15\text{ pF}$, Input a 25-MHz 50% duty cycle square wave			117.5	mW
P_{D1}	Maximum power dissipation (side-1)				47.7	mW
P_{D2}	Maximum power dissipation (side-2)				69.8	mW

6.6 Insulation Specifications

PARAMETER		TEST CONDITIONS	VALUE	UNIT
			DW-16	
CLR	External clearance ⁽¹⁾	Shortest terminal-to-terminal distance through air	>8	mm
CPG	External creepage ⁽¹⁾	Shortest terminal-to-terminal distance across the package surface	>8	mm
DTI	Distance through the insulation	Minimum internal gap (internal clearance)	>17	um
CTI	Comparative tracking index	DIN EN 60112 (VDE 0303-11); IEC 60112	>600	V
	Material group	According to IEC 60664-1	I	
	Overvoltage category per IEC 60664-1	Rated mains voltage ≤ 600 V _{RMS}	I-IV	
		Rated mains voltage ≤ 1000 V _{RMS}	I-III	
DIN VDE V 0884-11:2017-01 ⁽²⁾				
V _{IORM}	Maximum repetitive peak isolation voltage	AC voltage (bipolar)	1500	V _{PK}
V _{IOWM}	Maximum working isolation voltage	AC voltage; Time dependent dielectric breakdown (TDDb) Test; See Figure 9-4	1060	V _{RMS}
		DC voltage	1500	V _{DC}
V _{IOTM}	Maximum transient isolation voltage	V _{TEST} = V _{IOTM} , t = 60 s (qualification); V _{TEST} = 1.2 x V _{IOTM} , t= 1 s (100% production)	7071	V _{PK}
V _{IOSM}	Maximum surge isolation voltage ⁽³⁾	Test method per IEC 62368-1, 1.2/50 μs waveform, V _{TEST} = 1.6 x V _{IOSM} (qualification)	6250	V _{PK}
q _{pd}	Apparent charge ⁽⁴⁾	Method a, After Input-output safety test subgroup 2/3, V _{ini} = V _{IOTM} , t _{ini} = 60 s; V _{pd(m)} = 1.2 x V _{IORM} , t _m = 10 s	≤5	pC
		Method a, After environmental tests subgroup 1, V _{ini} = V _{IOTM} , t _{ini} = 60 s; V _{pd(m)} = 1.6 x V _{IORM} , t _m = 10 s	≤5	
		Method b; At routine test (100% production) and preconditioning (type test) V _{ini} = 1.2 x V _{IOTM} , t _{ini} = 1 s; V _{pd(m)} = 1.875 x V _{IORM} , t _m = 1 s	≤5	
C _{IO}	Barrier capacitance, input to output ⁽⁵⁾	V _{IO} = 0.4 x sin (2πft), f = 1 MHz	~1	pF
R _{IO}	Isolation resistance ⁽⁵⁾	V _{IO} = 500 V, T _A = 25°C	>10 ¹²	Ω
		V _{IO} = 500 V, 100°C ≤ T _A ≤ 125°C	>10 ¹¹	
		V _{IO} = 500 V at T _S = 150°C	>10 ⁹	
	Pollution degree		2	
	Climatic category		40/125/21	
UL 1577				
V _{ISO}	Maximum withstanding isolation voltage	V _{TEST} = V _{ISO} , t = 60 s (qualification), V _{TEST} = 1.2 x V _{ISO} , t = 1 s (100% production)	5000	V _{RMS}

- (1) Creepage and clearance requirements should be applied according to the specific equipment isolation standards of an application. Care should be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed-circuit board do not reduce this distance. Creepage and clearance on a printed-circuit board become equal in certain cases. Techniques such as inserting grooves and/or ribs on a printed-circuit board are used to help increase these specifications.
- (2) This coupler is suitable for *safe electrical insulation* only within the safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.
- (3) Testing is carried out in air or oil to determine the intrinsic surge immunity of the isolation barrier.
- (4) Apparent charge is electrical discharge caused by a partial discharge (pd).
- (5) All pins on each side of the barrier tied together creating a two-terminal device.

6.7 Safety-Related Certifications

VDE	CSA	UL	CQC	TUV
Plan to certify according to DIN VDE V 0884-11:2017-01	Plan to certify according to IEC 60950-1 and IEC 62368-1	Plan to certify according to UL 1577 Component Recognition Program	Plan to certify according to GB4943.1-2011	Plan to certify according to EN 61010-1:2010/A1:2019, EN 60950-1:2006/A2:2013 and EN 62368-1:2014
Maximum transient isolation voltage, 7071 V _{PK} ; Maximum repetitive peak isolation voltage, 1500 V _{PK} ; Maximum surge isolation voltage, 6250 V _{PK}	5000 V _{RMS} insulation per CSA 60950-1-07+A1+A2, IEC 60950-1 2nd Ed. +A1+A2, CSA 62368-1- 14 and IEC 62368-1:2014 800 V _{RMS} (DW-16) maximum working voltage (pollution degree 2, material group I)	Single protection, 5000 V _{RMS}	Reinforced insulation, Altitude ≤ 5000 m, Tropical Climate, 700 V _{RMS} maximum working voltage	5000 V _{RMS} insulation per EN 61010-1:2010 (3rd Ed) up to working voltage of 600 V _{RMS} 5000 V _{RMS} insulation per EN 60950- 1:2006/A2:2013 up to working voltage of 800 V _{RMS}
Certificate planned	Certificate planned	Certificate planned	Certificate planned	Certificate planned

6.8 Safety Limiting Values

Safety limiting⁽¹⁾ intends to minimize potential damage to the isolation barrier upon failure of input or output circuitry.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DW-16 PACKAGE						
I _S	Safety input, output, or supply current	R _{θJA} = 73°C/W, V _I = 5.5 V, T _J = 150°C, T _A = 25°C			311.4	mA
		R _{θJA} = 73°C/W, V _I = 3.6 V, T _J = 150°C, T _A = 25°C			475.7	mA
		R _{θJA} = 73°C/W, V _I = 2.75 V, T _J = 150°C, T _A = 25°C			622	
		R _{θJA} = 73°C/W, V _I = 1.89 V, T _J = 150°C, T _A = 25°C			905.1	mA
P _S	Safety input, output, or total power	R _{θJA} = 73°C/W, T _J = 150°C, T _A = 25°C			1712.4	mW
T _S	Maximum safety temperature				150	°C

- (1) The maximum safety temperature, T_S, has the same value as the maximum junction temperature, T_J, specified for the device. The I_S and P_S parameters represent the safety current and safety power respectively. The maximum limits of I_S and P_S should not be exceeded. These limits vary with the ambient temperature, T_A.
The junction-to-air thermal resistance, R_{θJA}, in the table is that of a device installed on a high-K test board for leaded surface-mount packages. Use these equations to calculate the value for each parameter:
T_J = T_A + R_{θJA} × P, where P is the power dissipated in the device.
T_{J(max)} = T_S = T_A + R_{θJA} × P_S, where T_{J(max)} is the maximum allowed junction temperature.
P_S = I_S × V_I, where V_I is the maximum input voltage.

6.9 Electrical Characteristics—5-V Supply

$V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage $I_{OH} = -4\text{ mA}$; See Figure 7-1	$V_{CCO} - 0.4$ ⁽¹⁾			V
V_{OL}	Low-level output voltage $I_{OL} = 4\text{ mA}$; See Figure 7-1			0.4	V
$V_{IT+(IN)}$	Rising input switching threshold		$0.7 \times V_{CCI}$ ⁽¹⁾		V
$V_{IT-(IN)}$	Falling input switching threshold	$0.3 \times V_{CCI}$			V
$V_{I(HYS)}$	Input threshold voltage hysteresis	$0.1 \times V_{CCI}$			V
I_{IH}	High-level input current $V_{IH} = V_{CCI}$ ⁽¹⁾ at INx			10	μA
I_{IL}	Low-level input current $V_{IL} = 0\text{ V}$ at INx	-10			μA
I_{IH}	High-level input current $V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx			28	μA
I_{IL}	Low-level input current $V_{IL} = 0\text{ V}$ at ENx	-28			μA
CMTI	Common mode transient immunity $V_I = V_{CC}$ or 0 V , $V_{CM} = 1200\text{ V}$; See Figure 7-1	50	75		kV/us
C_i	Input Capacitance ⁽²⁾ $V_I = V_{CC}/2 + 0.4 \times \sin(2\pi ft)$, $f = 2\text{ MHz}$, $V_{CC} = 5\text{ V}$		2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

6.10 Supply Current Characteristics—5-V Supply

$V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6731						
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6731); $V_I = 0\text{ V}$ (ISO6731 with F suffix)	I_{CC1}		1.8	3.5	mA
		I_{CC2}		2.4	4.7	
	$V_I = 0\text{ V}$ (ISO6731); $V_I = V_{CC1}$ (ISO6731 with F suffix)	I_{CC1}		4.1	6.6	
		I_{CC2}		3.5	6.1	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15\text{ pF}$	1 Mbps	I_{CC1}		2.9	5.0
			I_{CC2}		3.0	5.6
		10 Mbps	I_{CC1}		3.4	5.6
			I_{CC2}		4.2	6.9
		50 Mbps	I_{CC1}		6.1	8.7
			I_{CC2}		9.4	12.7

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for ENx = V_{CCx} and ENx = 0 V

(3) Supply current valid for ENx = V_{CCx}

6.11 Electrical Characteristics—3.3-V Supply

$V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage $I_{OH} = -2\text{mA}$; See Figure 7-1	$V_{CCO} - 0.2$ ⁽¹⁾			V
V_{OL}	Low-level output voltage $I_{OL} = 2\text{mA}$; See Figure 7-1			0.2	V
$V_{IT+(IN)}$	Rising input switching threshold		$0.7 \times V_{CCI}$ ⁽¹⁾		V
$V_{IT-(IN)}$	Falling input switching threshold	$0.3 \times V_{CCI}$			V
$V_{I(HYS)}$	Input threshold voltage hysteresis	$0.1 \times V_{CCI}$			V
I_{IH}	High-level input current $V_{IH} = V_{CCI}$ ⁽¹⁾ at INx			10	μA
I_{IL}	Low-level input current $V_{IL} = 0 \text{ V}$ at INx	-10			μA
I_{IH}	High-level input current $V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx			30	μA
I_{IL}	Low-level input current $V_{IL} = 0 \text{ V}$ at ENx	-30			μA
CMTI	Common mode transient immunity $V_I = V_{CC}$ or 0 V , $V_{CM} = 1200 \text{ V}$; See Figure 7-1	50	75		kV/us
C_i	Input Capacitance ⁽²⁾ $V_I = V_{CC}/2 + 0.4 \times \sin(2\pi ft)$, $f = 2 \text{ MHz}$, $V_{CC} = 3.3 \text{ V}$		2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

6.12 Supply Current Characteristics—3.3-V Supply

$V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6731						
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6731); $V_I = 0 \text{ V}$ (ISO6731 with F suffix)	I_{CC1}		1.7	3.5	mA
		I_{CC2}		2.3	4.7	
	$V_I = 0 \text{ V}$ (ISO6731); $V_I = V_{CC1}$ (ISO6731 with F suffix)	I_{CC1}		4.0	6.6	
		I_{CC2}		3.5	6.1	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$	1 Mbps	I_{CC1}	2.8	4.9	
			I_{CC2}	3.0	5.5	
		10 Mbps	I_{CC1}	3.2	5.4	
			I_{CC2}	3.8	6.5	
		50 Mbps	I_{CC1}	5.1	7.6	
			I_{CC2}	7.5	10.7	

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for ENx = V_{CCx} and ENx = 0 V

(3) Supply current valid for ENx = V_{CCx}

6.13 Electrical Characteristics—2.5-V Supply

$V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage $I_{OH} = -1\text{mA}$; See Figure 7-1	$V_{CCO} - 0.1$ ⁽¹⁾			V
V_{OL}	Low-level output voltage $I_{OL} = 1\text{mA}$; See Figure 7-1			0.1	V
$V_{IT+(IN)}$	Rising input switching threshold		$0.7 \times V_{CCI}$ ⁽¹⁾		V
$V_{IT-(IN)}$	Falling input switching threshold	$0.3 \times V_{CCI}$			V
$V_{I(HYS)}$	Input threshold voltage hysteresis	$0.1 \times V_{CCI}$			V
I_{IH}	High-level input current $V_{IH} = V_{CCI}$ ⁽¹⁾ at INx			10	μA
I_{IL}	Low-level input current $V_{IL} = 0 \text{ V}$ at INx	-10			μA
I_{IH}	High-level input current $V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx			30	μA
I_{IL}	Low-level input current $V_{IL} = 0 \text{ V}$ at ENx	-30			μA
CMTI	Common mode transient immunity $V_I = V_{CC}$ or 0 V , $V_{CM} = 1200 \text{ V}$; See Figure 7-1	50	75		kV/us
C_i	Input Capacitance ⁽²⁾ $V_I = V_{CC}/2 + 0.4 \times \sin(2\pi ft)$, $f = 2 \text{ MHz}$, $V_{CC} = 2.5 \text{ V}$		2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

6.14 Supply Current Characteristics—2.5-V Supply

$V_{CC1} = V_{CC2} = 2.5 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6731						
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6731); $V_I = 0 \text{ V}$ (ISO6731 with F suffix)	I_{CC1}		1.7	3.5	mA
		I_{CC2}		2.3	4.6	
	$V_I = 0 \text{ V}$ (ISO6731); $V_I = V_{CC1}$ (ISO6731 with F suffix)	I_{CC1}		4.0	6.5	
		I_{CC2}		3.5	6.1	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$	1 Mbps	I_{CC1}	2.8	4.9	
	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$		I_{CC2}	3.0	5.5	
	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$	10 Mbps	I_{CC1}	3.1	5.3	
	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$		I_{CC2}	3.6	6.2	
	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$	50 Mbps	I_{CC1}	4.5	7.0	
	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$		I_{CC2}	6.4	9.5	

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for $ENx = V_{CCx}$ and $ENx = 0 \text{ V}$

(3) Supply current valid for $ENx = V_{CCx}$

6.15 Electrical Characteristics—1.8-V Supply

$V_{CC1} = V_{CC2} = 1.8 \text{ V} \pm 5\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -1 \text{ mA}$; See Figure 7-1	$V_{CCO} - 0.1$ ⁽¹⁾		V
V_{OL}	Low-level output voltage	$I_{OL} = 1 \text{ mA}$; See Figure 7-1		0.1	V
$V_{IT+(IN)}$	Rising input switching threshold		$0.7 \times V_{CCI}$ ⁽¹⁾		V
$V_{IT-(IN)}$	Falling input switching threshold		$0.3 \times V_{CCI}$		V
$V_{I(HYS)}$	Input threshold voltage hysteresis		$0.1 \times V_{CCI}$		V
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at INx		10	μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at INx	-10		μA
I_{IH}	High-level input current	$V_{IH} = V_{CCI}$ ⁽¹⁾ at ENx		30	μA
I_{IL}	Low-level input current	$V_{IL} = 0 \text{ V}$ at ENx	-30		μA
CMTI	Common mode transient immunity	$V_I = V_{CC}$ or 0 V , $V_{CM} = 1200 \text{ V}$; See Figure 7-1	50	75	kV/us
C_i	Input Capacitance ⁽²⁾	$V_I = V_{CC}/2 + 0.4 \times \sin(2\pi ft)$, $f = 2 \text{ MHz}$, $V_{CC} = 1.8 \text{ V}$	2.8		pF

(1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC}

(2) Measured from input pin to same side ground.

6.16 Supply Current Characteristics—1.8-V Supply

$V_{CC1} = V_{CC2} = 1.8 \text{ V} \pm 5\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER	TEST CONDITIONS	SUPPLY CURRENT	MIN	TYP	MAX	UNIT
ISO6731						
Supply current - DC signal ⁽²⁾	$V_I = V_{CCI}$ ⁽¹⁾ (ISO6731); $V_I = 0 \text{ V}$ (ISO6731 with F suffix)	I_{CC1}		1.4	2.4	mA
		I_{CC2}		2.2	3.8	
	$V_I = 0 \text{ V}$ (ISO6731); $V_I = V_{CC1}$ (ISO6731 with F suffix)	I_{CC1}		3.4	5.4	
		I_{CC2}		3.2	5.3	
Supply current - AC signal ⁽³⁾	All channels switching with square wave clock input; $C_L = 15 \text{ pF}$	1 Mbps	I_{CC1}	2.4	3.8	
			I_{CC2}	2.7	4.6	
		10 Mbps	I_{CC1}	2.6	4.1	
			I_{CC2}	3.2	5.1	
		50 Mbps	I_{CC1}	3.7	5.3	
			I_{CC2}	5.2	7.4	

(1) V_{CCI} = Input-side V_{CC}

(2) Supply current valid for ENx = V_{CCx} and ENx = 0V

(3) Supply current valid for ENx = V_{CCx}

6.17 Switching Characteristics—5-V Supply

$V_{CC1} = V_{CC2} = 5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}, t_{PHL}	Propagation delay time	@100kbps		11	18	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $	See Figure 7-1		0.2	7	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				6	ns
t_r	Output signal rise time	See Figure 7-1		2.6	4.5	ns
t_f	Output signal fall time			2.6	4.5	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 7-2		18.6	25.8	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			18.6	25.8	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO673x			14.2	21.1	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO673x			14.2	21.1	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 7-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

- (1) Also known as pulse skew.
 (2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
 (3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

6.18 Switching Characteristics—3.3-V Supply

$V_{CC1} = V_{CC2} = 3.3 \text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	@100kbps		11	18	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $	See Figure 7-1		0.5	7	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				7	ns
t_r	Output signal rise time	See Figure 7-1		1.6	3.2	ns
t_f	Output signal fall time			1.6	3.2	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 7-2		23.2	34.4	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			23.2	34.4	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO673x			16.6	23	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO673x			16.6	23	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 7-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

(1) Also known as pulse skew.

(2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

(3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

6.19 Switching Characteristics—2.5-V Supply

$V_{CC1} = V_{CC2} = 2.5\text{ V} \pm 10\%$ (over recommended operating conditions unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	@100kbps		12	20.5	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $	See Figure 7-1		0.6	7.1	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				7	ns
t_r	Output signal rise time	See Figure 7-1		2	4	ns
t_f	Output signal fall time			2	4	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 7-2		28.1	43	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			28.1	43	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO673x			20.4	36.3	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO673x			20.4	36.3	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 7-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

- (1) Also known as pulse skew.
 (2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.
 (3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

6.20 Switching Characteristics—1.8-V Supply

$V_{CC1} = V_{CC2} = 1.8 \text{ V} \pm 5\%$ (over recommended operating conditions unless otherwise noted)

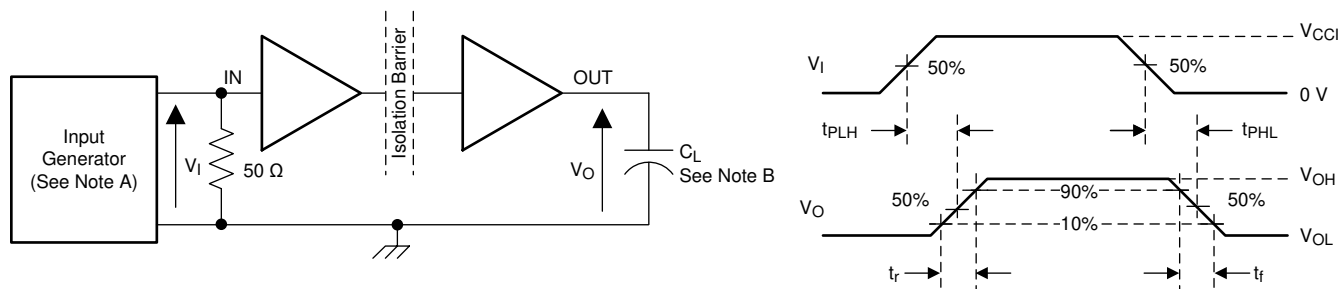
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay time	@100kbps		15	24	ns
PWD	Pulse width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $	See Figure 7-1		0.7	8.2	ns
$t_{sk(o)}$	Channel-to-channel output skew time ⁽²⁾	Same-direction channels			6	ns
$t_{sk(pp)}$	Part-to-part skew time ⁽³⁾				8.8	ns
t_r	Output signal rise time	See Figure 7-1		2.7	5.3	ns
t_f	Output signal fall time			2.7	5.3	ns
t_{PHZ}	Disable propagation delay, high-to-high impedance output	See Figure 7-2		40.3	63	ns
t_{PLZ}	Disable propagation delay, low-to-high impedance output			40.3	63	ns
t_{PZH}	Enable propagation delay, high impedance-to-high output for ISO673x			30	51.4	ns
t_{PZL}	Enable propagation delay, high impedance-to-low output for ISO673x			30	51.4	ns
t_{PU}	Time from UVLO to valid output data				300	us
t_{DO}	Default output delay time from input power loss	Measured from the time VCC goes below 1.2V. See Figure 7-3		0.1	0.3	us
t_{ie}	Time interval error	$2^{16} - 1$ PRBS data at 50 Mbps		1		ns

(1) Also known as pulse skew.

(2) $t_{sk(o)}$ is the skew between outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical loads.

(3) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any terminals of different devices switching in the same direction while operating at identical supply voltages, temperature, input signals and loads.

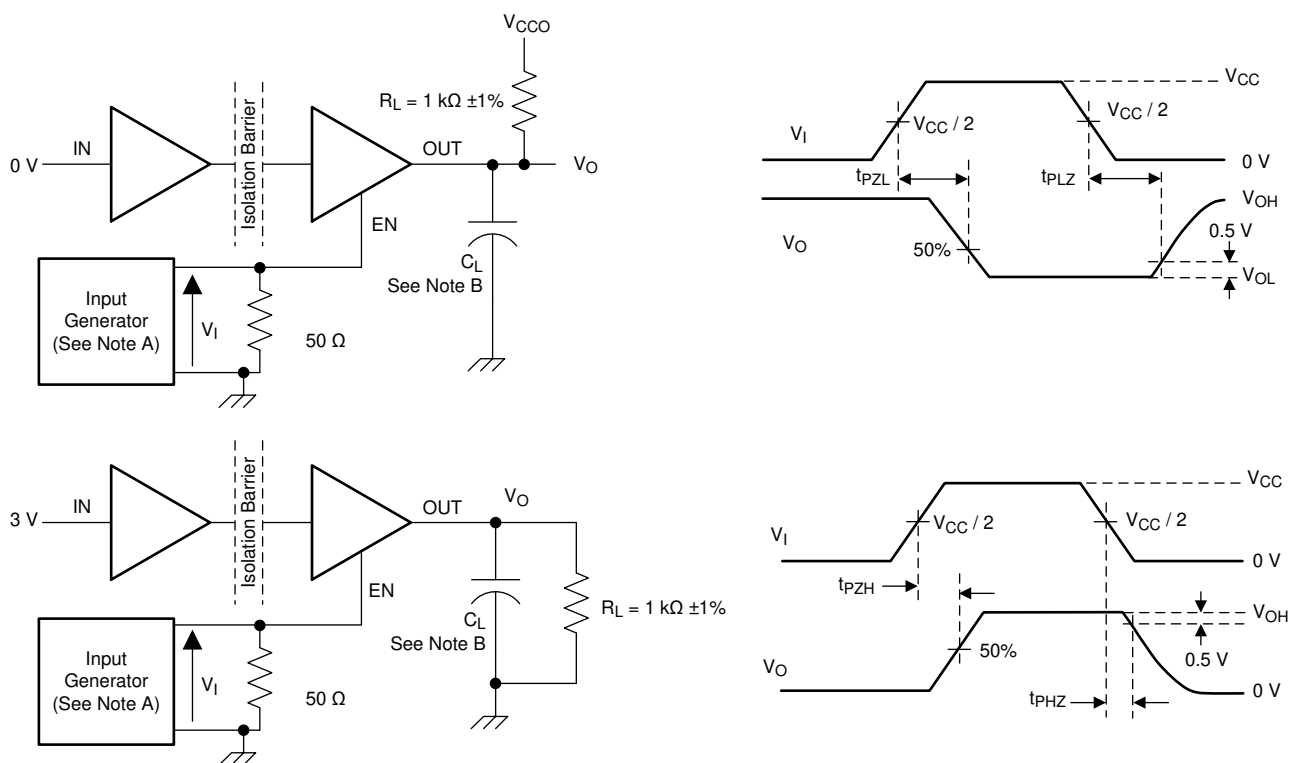
7 Parameter Measurement Information



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- A. The input pulse is supplied by a generator having the following characteristics: PRR $\leq$ 50 kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_O = 50 \Omega$. At the input, 50 Ω resistor is required to terminate Input Generator signal. It is not needed in actual application.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

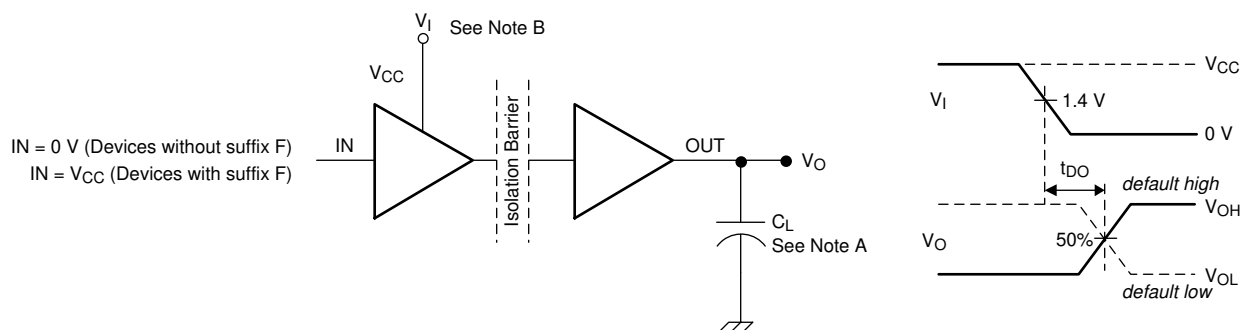
Figure 7-1. Switching Characteristics Test Circuit and Voltage Waveforms



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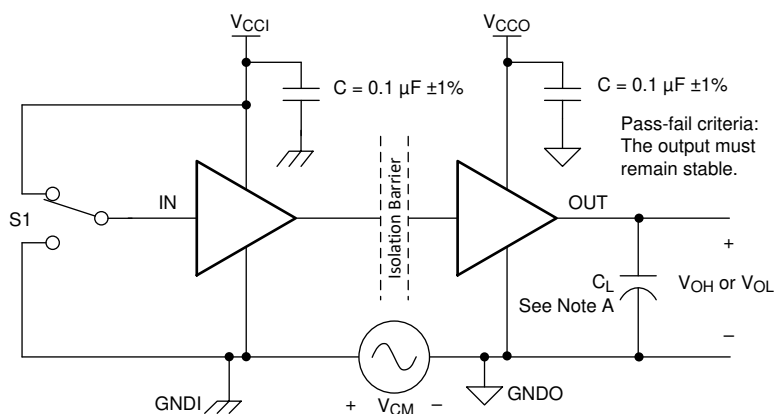
- A. The input pulse is supplied by a generator having the following characteristics: PRR $\leq$ 10 kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_O = 50 \Omega$.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 7-2. Enable/Disable Propagation Delay Time Test Circuit and Waveform



- A. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.
B. Power Supply Ramp Rate = 10 mV/ns

Figure 7-3. Default Output Delay Time Test Circuit and Voltage Waveforms



- A. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 7-4. Common-Mode Transient Immunity Test Circuit

8 Detailed Description

8.1 Overview

The ISO6731 device has an ON-OFF keying (OOK) modulation scheme to transmit the digital data across a silicon dioxide based isolation barrier. The transmitter sends a high frequency carrier across the barrier to represent one digital state and sends no signal to represent the other digital state. The receiver demodulates the signal after advanced signal conditioning and produces the output through a buffer stage. If the ENx pin is low then the output goes to high impedance. The ISO6731 device also incorporate advanced circuit techniques to maximize the CMTI performance and minimize the radiated emissions due to the high frequency carrier and IO buffer switching. The conceptual block diagram of a digital capacitive isolator, [Figure 8-1](#), shows a functional block diagram of a typical channel.

8.2 Functional Block Diagram

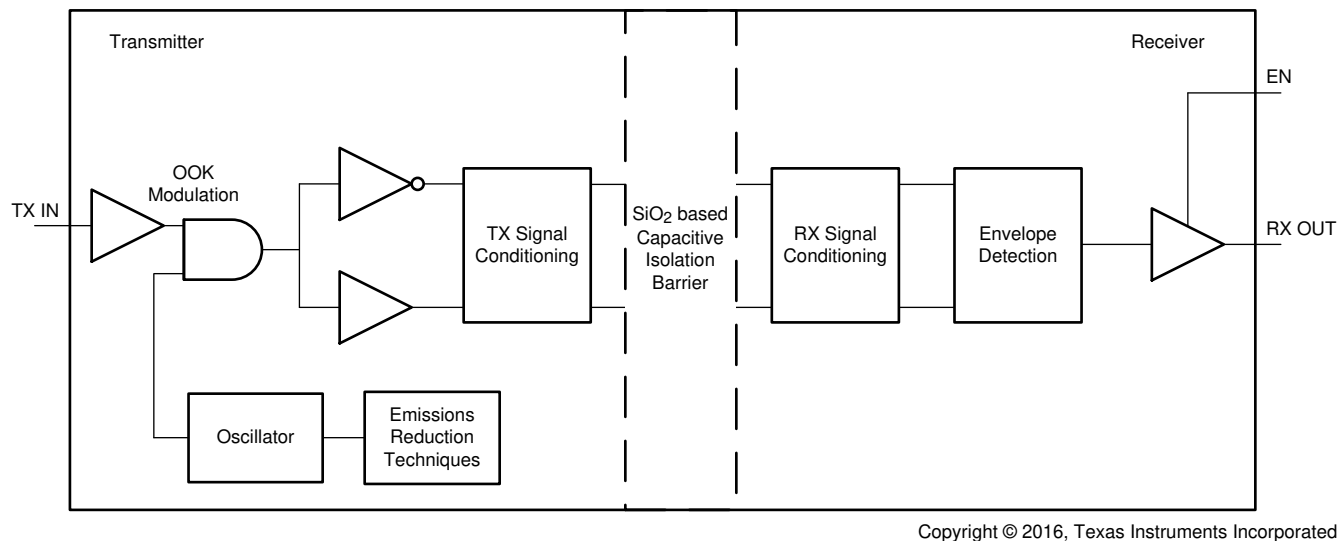


Figure 8-1. Conceptual Block Diagram of a Digital Capacitive Isolator

[Figure 8-2](#) shows a conceptual detail of how the ON-OFF keying scheme works.

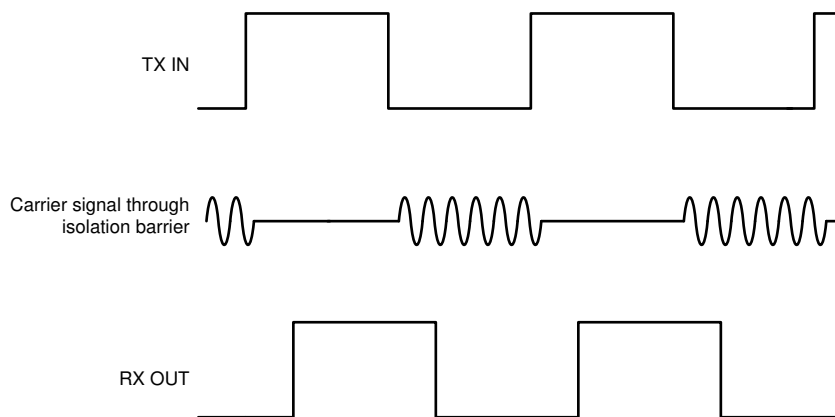


Figure 8-2. On-Off Keying (OOK) Based Modulation Scheme

8.3 Feature Description

Table 8-1 provides an overview of the device features.

Table 8-1. Device Features

PART NUMBER	CHANNEL DIRECTION	MAXIMUM DATA RATE	DEFAULT OUTPUT	PACKAGE	RATED ISOLATION ⁽¹⁾
ISO6731	2 Forward, 1 Reverse	50 Mbps	High	DW-16	5000 V _{RMS} / 8000 V _{PK}
ISO6731F	2 Forward, 1 Reverse	50 Mbps	Low	DW-16	5000 V _{RMS} / 8000 V _{PK}

(1) See for detailed isolation ratings.

8.3.1 Electromagnetic Compatibility (EMC) Considerations

Many applications in harsh industrial environment are sensitive to disturbances such as electrostatic discharge (ESD), electrical fast transient (EFT), surge and electromagnetic emissions. These electromagnetic disturbances are regulated by international standards such as IEC 61000-4-x and CISPR 22. Although system-level performance and reliability depends, to a large extent, on the application board design and layout, the ISO6731 device incorporates many chip-level design improvements for overall system robustness. Some of these improvements include:

- Robust ESD protection cells for input and output signal pins and inter-chip bond pads.
- Low-resistance connectivity of ESD cells to supply and ground pins.
- Enhanced performance of high voltage isolation capacitor for better tolerance of ESD, EFT and surge events.
- Bigger on-chip decoupling capacitors to bypass undesirable high energy signals through a low impedance path.
- PMOS and NMOS devices isolated from each other by using guard rings to avoid triggering of parasitic SCRs.
- Reduced common mode currents across the isolation barrier by ensuring purely differential internal operation.

8.4 Device Functional Modes

Table 8-2 lists the functional modes for the ISO6731 device.

Table 8-2. Function Table

$V_{CCI}^{(1)}$	V_{CCO}	INPUT (INx) ⁽³⁾	OUTPUT ENABLE (ENx)	OUTPUT (OUTx)	COMMENTS
PU	PU	H	H or open	H	Normal Operation: A channel output assumes the logic state of its input.
		L	H or open	L	
		Open	H or open	Default	Default mode: When INx is open, the corresponding channel output goes to its default logic state. Default is <i>High</i> for ISO6731 and <i>Low</i> for ISO6731 with F suffix.
X	PU	X	L	Z	A low value of output enable causes the outputs to be high-impedance.
PD	PU	X	H or open	Default	Default mode: When V_{CCI} is unpowered, a channel output assumes the logic state based on the selected default option. Default is <i>High</i> for ISO6731 and <i>Low</i> for ISO6731 with F suffix. When V_{CCI} transitions from unpowered to powered-up, a channel output assumes the logic state of the input. When V_{CCI} transitions from powered-up to unpowered, channel output assumes the selected default state.
X	PD	X	X	Undetermined	When V_{CCO} is unpowered, a channel output is undetermined ⁽²⁾ . When V_{CCO} transitions from unpowered to powered-up, a channel output assumes the logic state of the input.

- (1) V_{CCI} = Input-side V_{CC} ; V_{CCO} = Output-side V_{CC} ; PU = Powered up ($V_{CC} \geq 1.71$ V); PD = Powered down ($V_{CC} \leq 1.05$ V); X = Irrelevant; H = High level; L = Low level; Z = High Impedance
(2) The outputs are in undetermined state when 1.7 V < V_{CCI} , $V_{CCO} < 2.25$ V and 1.05 V < V_{CCI} , $V_{CCO} < 1.71$ V
(3) A strongly driven input signal can weakly power the floating V_{CC} through an internal protection diode and cause undetermined output

8.4.1 Device I/O Schematics

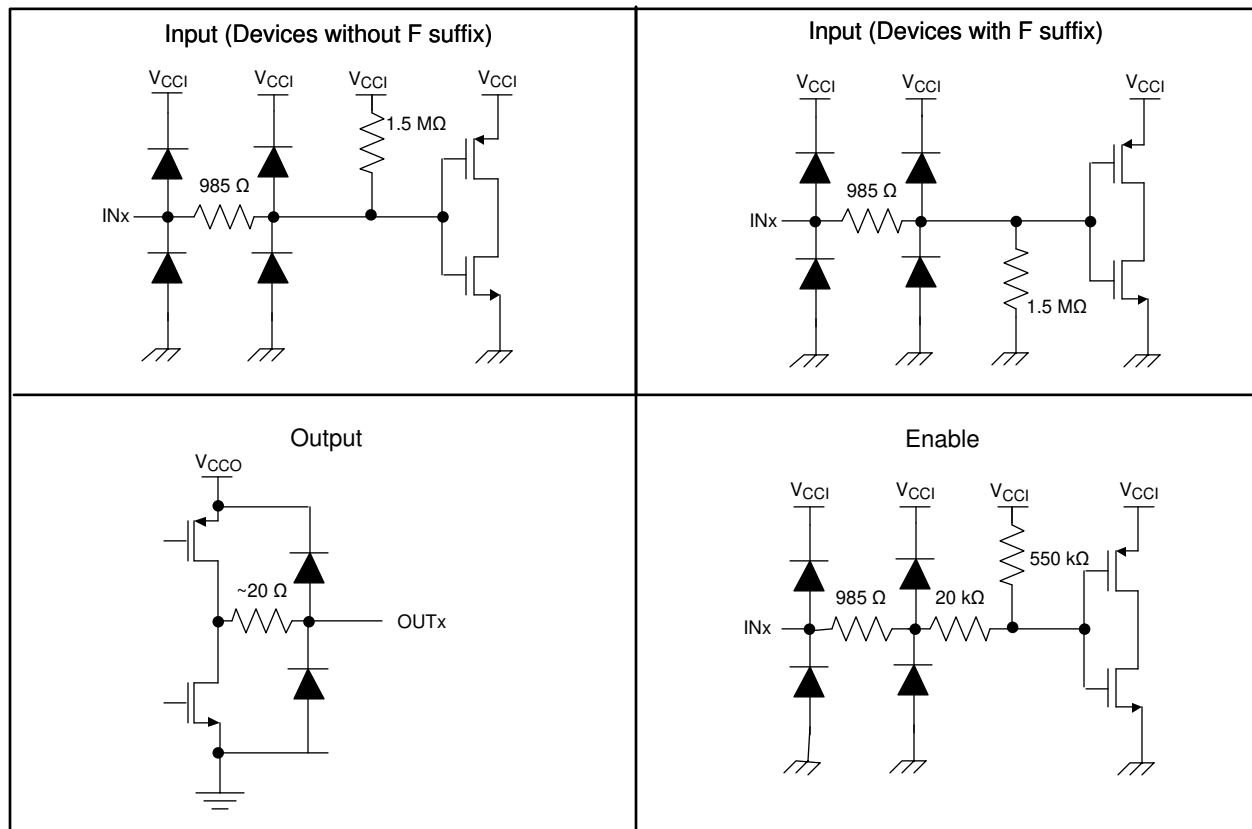


Figure 8-3. Device I/O Schematics

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The ISO6731 device is a high-performance, triple-channel digital isolators. This device comes with enable pins on each side which can be used to put the respective outputs in high impedance for multi master driving applications. The ISO6731 device uses single-ended CMOS-logic switching technology. The supply voltage range is from 1.71 V to 5.5 V for both supplies, V_{CC1} and V_{CC2} . Since an isolation barrier separates the two sides, each side can be sourced independently with any voltage within recommended operating conditions. As an example, it is possible to supply ISO6731 V_{CC1} with 3.3 V (which is within 1.71 V to 5.5 V) and V_{CC2} with 5V (which is also within 1.71 V to 5.5 V). You can use the digital isolator as a logic-level translator in addition to providing isolation. When designing with digital isolators, keep in mind that because of the single-ended design structure, digital isolators do not conform to any specific interface standard and are only intended for isolating single-ended CMOS or TTL digital signal lines. The isolator is typically placed between the data controller (that is, μC or UART), and a data converter or a line transceiver, regardless of the interface type or standard.

9.2 Typical Application

9.2.1 Design Requirements

To design with this device, use the parameters listed in [Table 9-1](#).

Table 9-1. Design Parameters

PARAMETER	VALUE
Supply voltage, V_{CC1} and V_{CC2}	1.71 V to 1.89 V and 2.25 V to 5.5 V
Decoupling capacitor between V_{CC1} and GND1	0.1 μ F
Decoupling capacitor from V_{CC2} and GND2	0.1 μ F

9.2.2 Detailed Design Procedure

Unlike optocouplers, which require external components to improve performance, provide bias, or limit current, the ISO6731 device only requires two external bypass capacitors to operate.

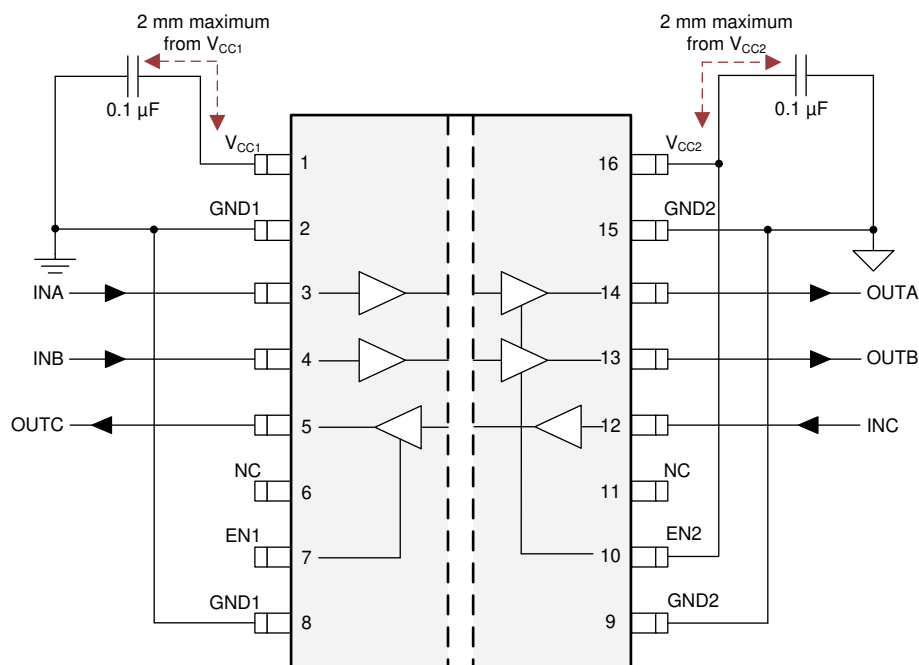


Figure 9-1. Typical ISO6731 Circuit Hook-up

9.2.3 Application Curve

The following typical eye diagrams of the ISO6731 device indicates low jitter and wide open eye at the maximum data rate of 50 Mbps.

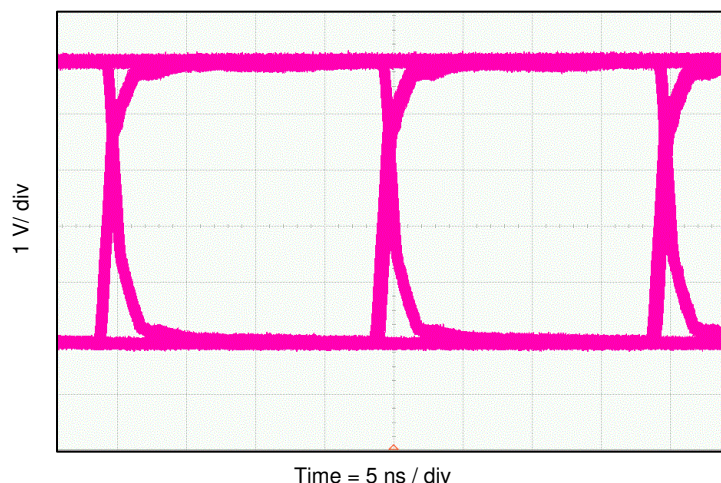


Figure 9-2. Eye Diagram at 50 Mbps PRBS 2¹⁶ – 1, 5 V and 25°C

9.2.3.1 Insulation Lifetime

Insulation lifetime projection data is collected by using industry-standard Time Dependent Dielectric Breakdown (TDDB) test method. In this test, all pins on each side of the barrier are tied together creating a two-terminal device and high voltage applied between the two sides; See [Figure 9-3](#) for TDDB test setup. The insulation breakdown data is collected at various high voltages switching at 60 Hz over temperature. For reinforced insulation, VDE standard requires the use of TDDB projection line with failure rate of less than 1 part per million (ppm). Even though the expected minimum insulation lifetime is 20 years at the specified working isolation voltage, VDE reinforced certification requires additional safety margin of 20% for working voltage and 87.5% for lifetime which translates into minimum required insulation lifetime of 37.5 years at a working voltage that's 20% higher than the specified value.

[Figure 9-4](#) shows the intrinsic capability of the isolation barrier to withstand high voltage stress over its lifetime. Based on the TDDB data, the intrinsic capability of the insulation is 1060 V_{RMS} with a lifetime of 220 years. Other factors, such as package size, pollution degree, material group, etc. can further limit the working voltage of the component. The working voltage of DW-16 package is specified upto 1060 V_{RMS}. At the lower working voltages, the corresponding insulation lifetime is much longer than 220 years.

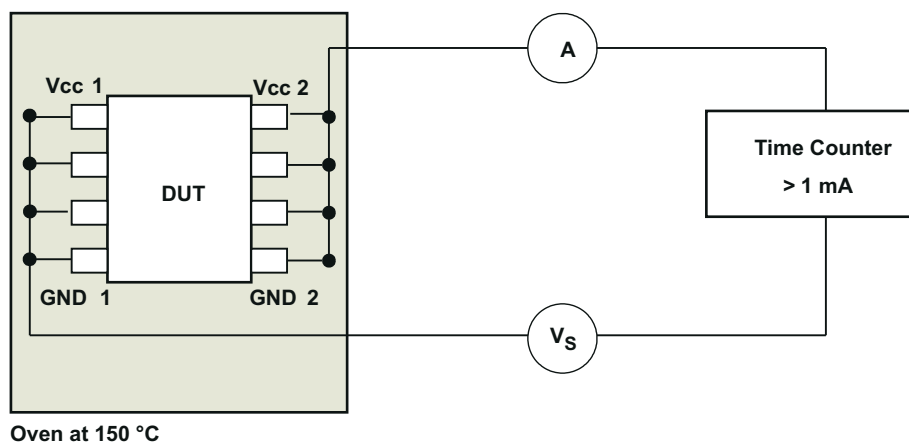


Figure 9-3. Test Setup for Insulation Lifetime Measurement

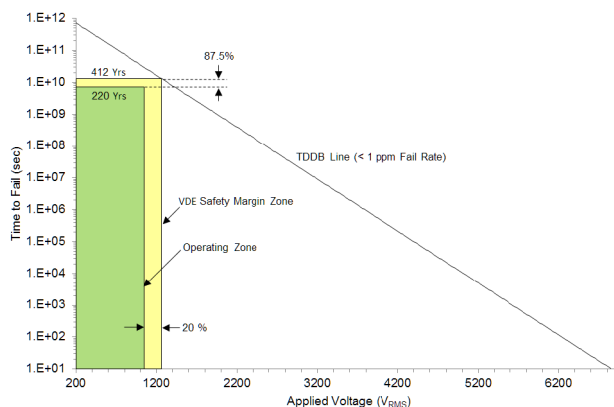


Figure 9-4. Insulation Lifetime Projection Data

10 Power Supply Recommendations

To help ensure reliable operation at data rates and supply voltages, a 0.1- μ F bypass capacitor is recommended at the input and output supply pins (V_{CC1} and V_{CC2}). The capacitors should be placed as close to the supply pins as possible. If only a single primary-side power supply is available in an application, isolated power can be generated for the secondary-side with the help of a transformer driver. For industrial applications, please use Texas Instruments' [SN6501](#) or [SN6505A](#). For such applications, detailed power supply design and transformer selection recommendations are available in [SN6501 Transformer Driver for Isolated Power Supplies](#) or [SN6505 Low-Noise 1-A Transformer Drivers for Isolated Power Supplies](#).

11 Layout

11.1 Layout Guidelines

A minimum of two layers is required to accomplish a cost optimized and low EMI PCB design. To further improve EMI, a four layer board can be used (see [Figure 11-2](#)). Layer stacking should be in the following order (top-to-bottom): high-speed signal layer, ground plane, power plane and low-frequency signal layer.

- Routing the high-speed traces on the top layer avoids the use of vias (and the introduction of their inductances) and allows for clean interconnects between the isolator and the transmitter and receiver circuits of the data link.
- Placing a solid ground plane next to the high-speed signal layer establishes controlled impedance for transmission line interconnects and provides an excellent low-inductance path for the return current flow.
- Placing the power plane next to the ground plane creates additional high-frequency bypass capacitance of approximately 100 pF/inch².
- Routing the slower speed control signals on the bottom layer allows for greater flexibility as these signal links usually have margin to tolerate discontinuities such as vias.

If an additional supply voltage plane or signal layer is needed, add a second power or ground plane system to the stack to keep it symmetrical. This makes the stack mechanically stable and prevents it from warping. Also the power and ground plane of each power system can be placed closer together, thus increasing the high-frequency bypass capacitance significantly.

For detailed layout recommendations, refer to the [Digital Isolator Design Guide](#).

11.1.1 PCB Material

For digital circuit boards operating below 150 Mbps, (or rise and fall times higher than 1 ns), and trace lengths of up to 10 inches, use standard FR-4 UL94V-0 printed circuit boards. This PCB is preferred over cheaper alternatives due to its lower dielectric losses at high frequencies, less moisture absorption, greater strength and stiffness, and self-extinguishing flammability-characteristics.

11.2 Layout Example

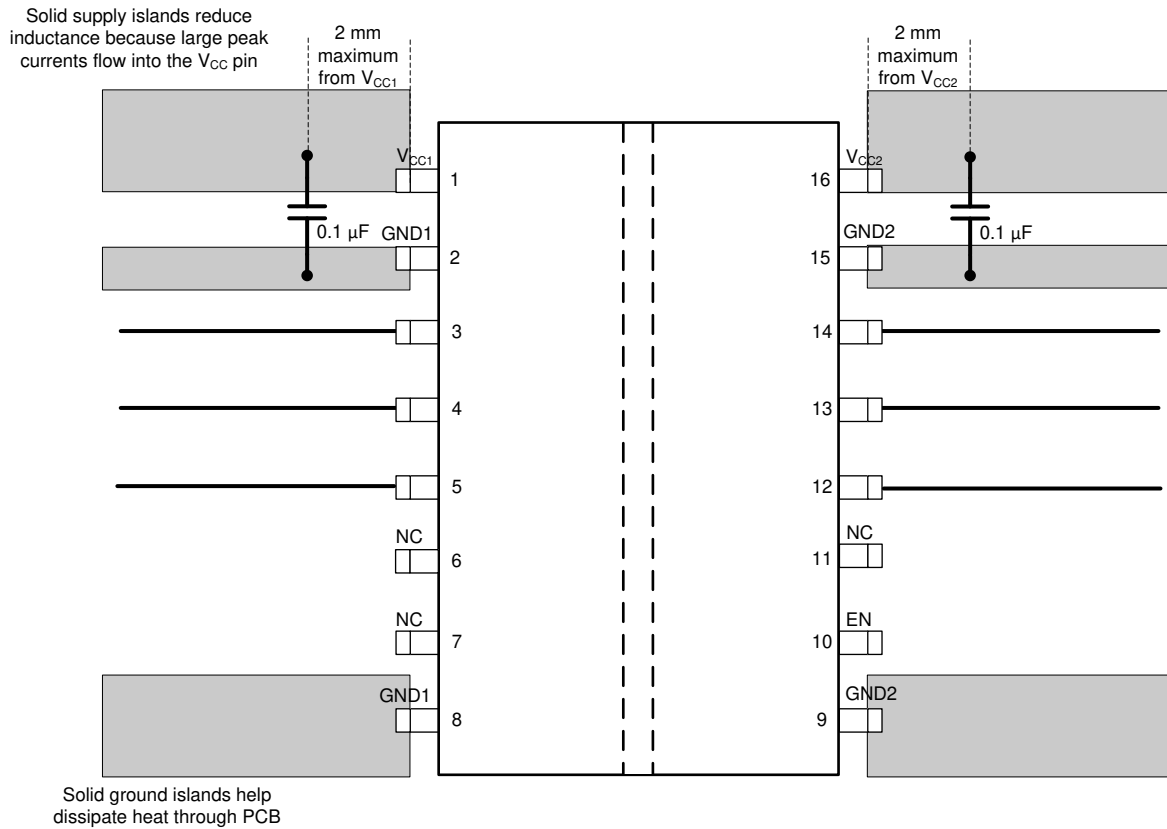


Figure 11-1. Layout Example

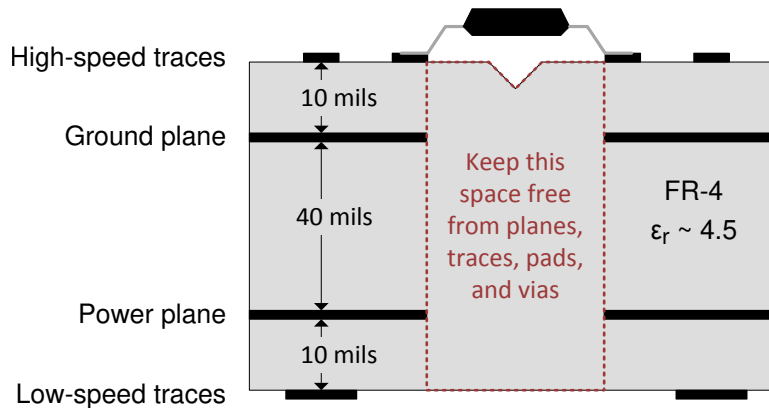


Figure 11-2. Layout Example Schematic

12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Digital Isolator Design Guide](#)
- Texas Instruments, [ADS79xx 12/10/8-Bit, 1 MSPS, 16/12/8/4-Channel, Single-Ended, MicroPower, Serial Interface ADCs data sheet](#)
- Texas Instruments, [Digital Isolator Design Guide](#)
- Texas Instruments, [Isolation Glossary](#)
- Texas Instruments, [How to use isolation to improve ESD, EFT, and Surge immunity in industrial systems application report](#)
- Texas Instruments, [DAC161P997 Single-Wire 16-bit DAC for 4- to 20-mA Loops data sheet](#)
- Texas Instruments, [MSP430G2132 Mixed Signal Microcontroller data sheet](#)
- Texas Instruments, [SN6501 Transformer Driver for Isolated Power Supplies data sheet](#)
- Texas Instruments, [TPS76333 Low-Power 150-mA Low-Dropout Linear Regulators data sheet](#)

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

12.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

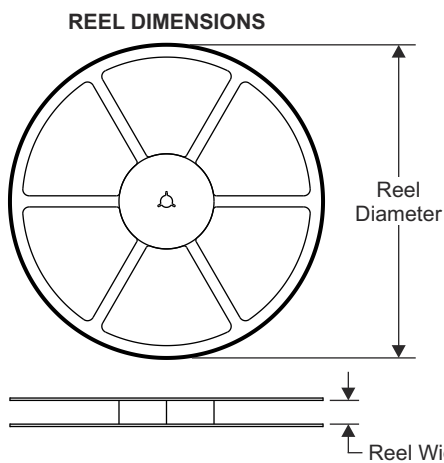
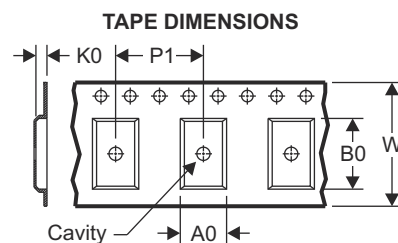
The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated device. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

13.1 Package Option Addendum

Packaging Information

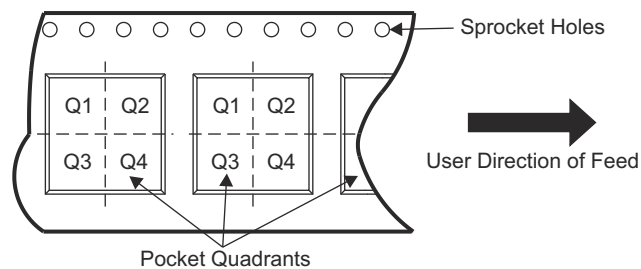
Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish ⁽⁶⁾	MSL Peak Temp ⁽³⁾	Op Temp (°C)	Device Marking ^{(4) (5)}
XISO6731DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	XISO6731Q
XISO6731FDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	--40 to 125	XISO6731FQ

13.2 Tape and Reel Information



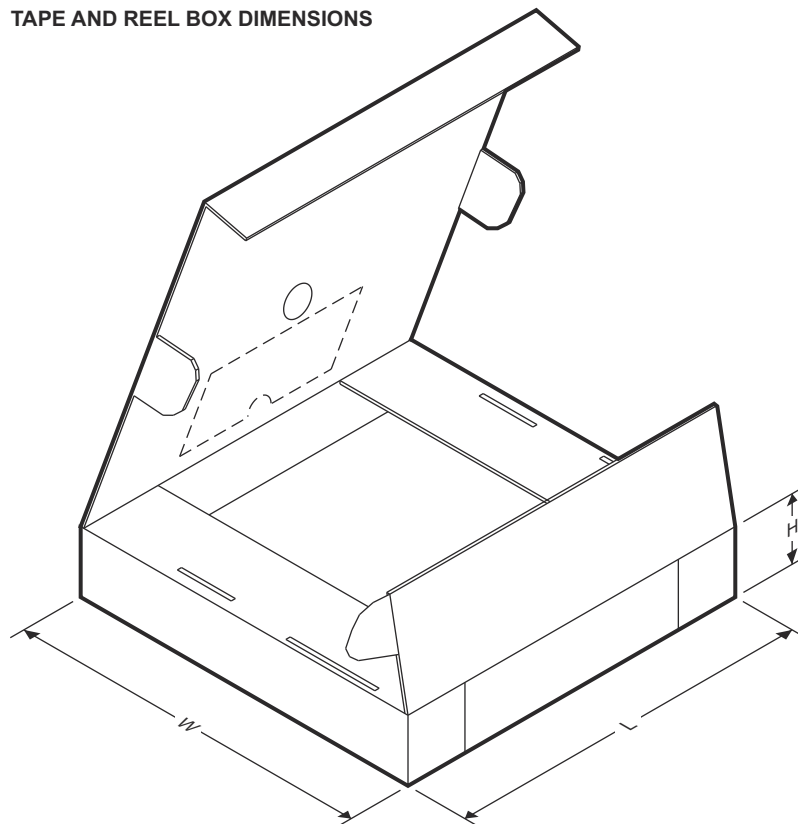
A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO6731DWR	SOIC	DW	16	2000	330.0	24.40	10.9	10.7	2.7	16.0	24.0	Q1
ISO6731FDWR	SOIC	DW	16	2000	330.0	24.40	10.9	10.7	2.7	16.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS



Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO6731DWR	SOIC	DW	16	2000	367.0	367.0	45.0
ISO6731FDWR	SOIC	DW	16	2000	367.0	367.0	45.0

ADVANCE INFORMATION

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ISO6731DWR	PREVIEW	SOIC	DW	16	2000	RoHS (In work) & Green (In work)	Call TI	Call TI	-40 to 125		
ISO6731FDWR	PREVIEW	SOIC	DW	16	2000	RoHS (In work) & Green (In work)	Call TI	Call TI	-40 to 125		
XISO6731DWR	ACTIVE	SOIC	DW	16	2000	RoHS (In work) & Green (In work)	Call TI	Call TI	-40 to 125		Samples
XISO6731FDWR	ACTIVE	SOIC	DW	16	2000	RoHS (In work) & Green (In work)	Call TI	Call TI	-40 to 125		Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF ISO6731 :

- Automotive: [ISO6731-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

GENERIC PACKAGE VIEW

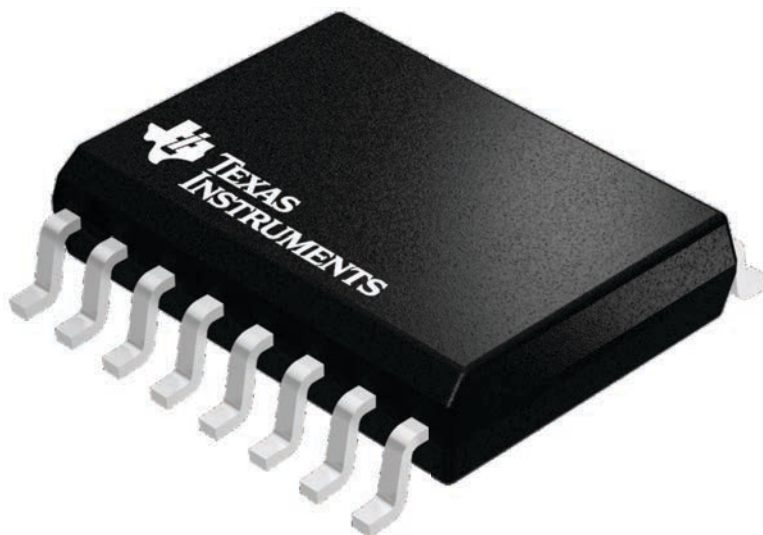
DW 16

SOIC - 2.65 mm max height

7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



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